

# Search Notes



Application/Control No.

10/698,892

Examiner

Hiep Nguyen

Applicant(s)/Patent under Reexamination

TAM ET AL.

Art Unit

2816

## SEARCHED

Class	Subclass	Date	Examiner
327	198	07.13.04	Hu
	199	↓	↓
	200		
	203		
	211		
	212		
	218	↓	↓
Updated Search		06.26.05	Hu

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	07.14.04	Hu